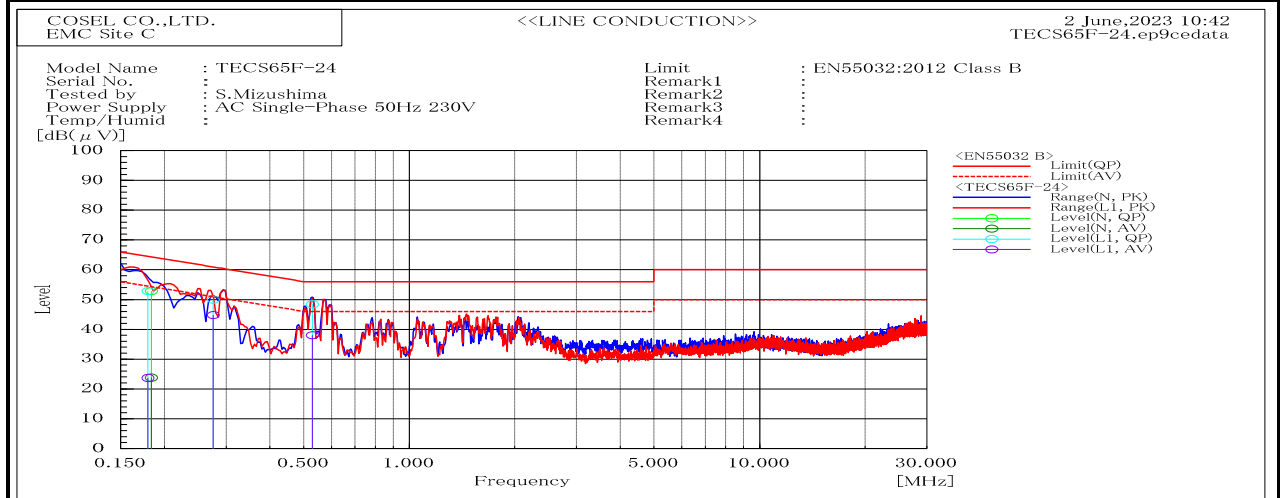
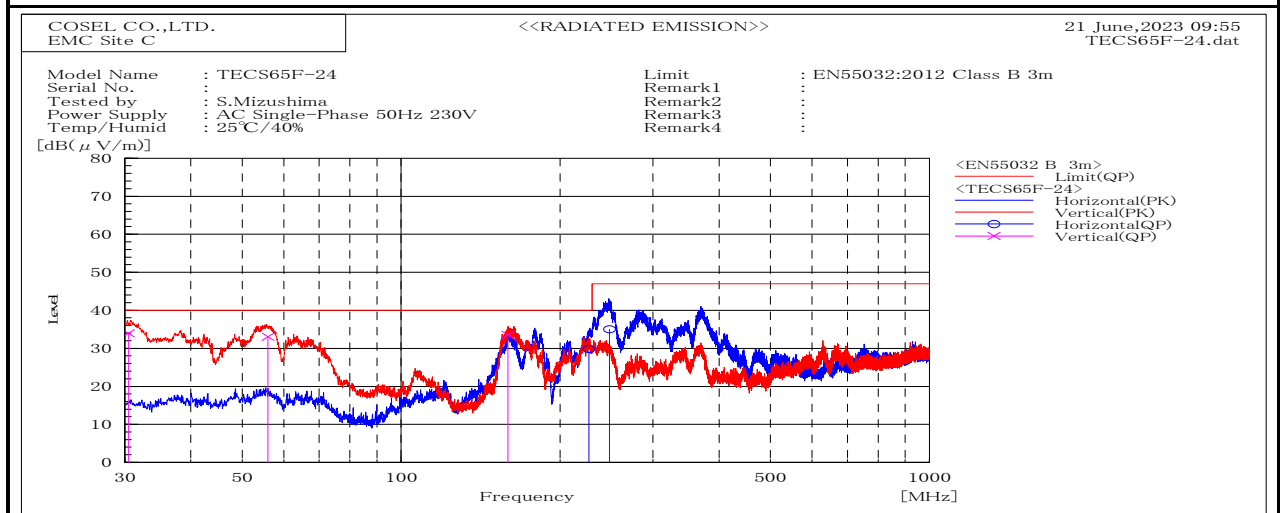


DATA SHEET		Date	12-Oct-23
Model	TECS65F-24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima



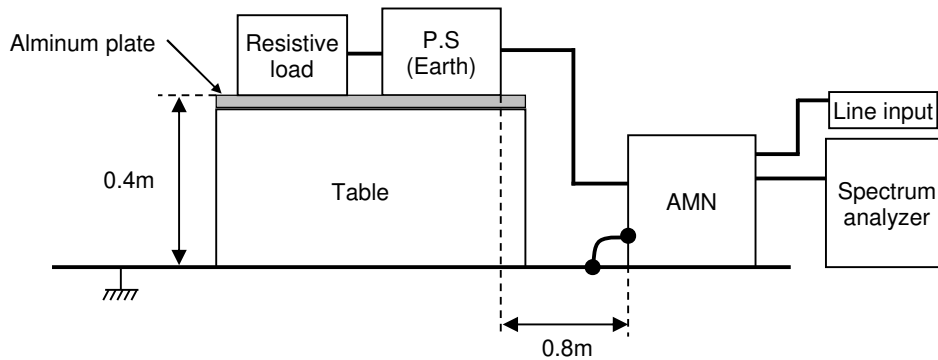
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.179	L1	52.8	23.7	64.5	54.5	11.7	30.8	Pass	
0.275	L1	50	44.8	61	51	11	6.2	Pass	
0.529	L1	48.4	38.1	56	46	7.6	7.9	Pass	
0.184	N	52.9	23.8	64.3	54.3	11.4	30.5	Pass	



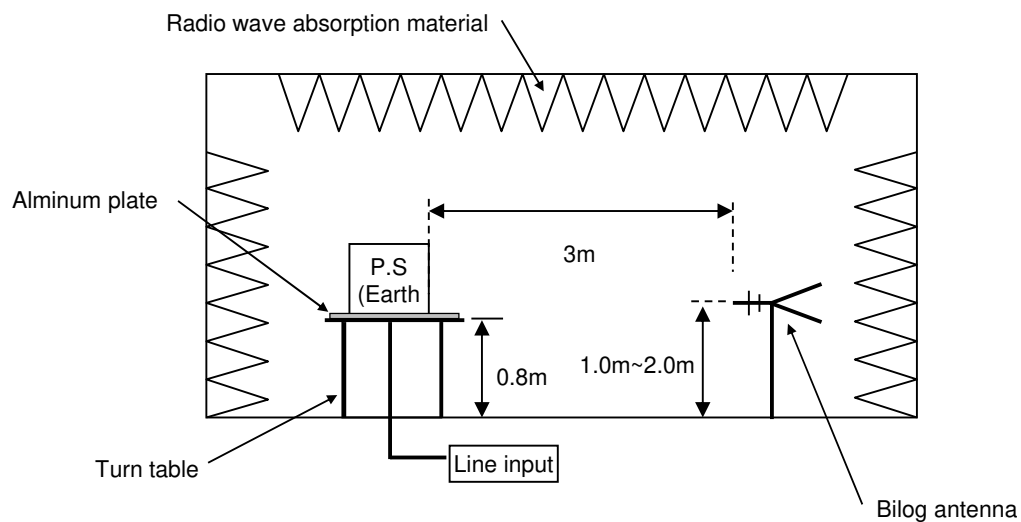
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP		cm	deg	
30.434	V	Stable	34	40	6	Pass	100.4	339.9	
55.976	V	Stable	33.1	40	6.9	Pass	100.4	17.4	
159.245	V	Stable	33.6	40	6.4	Pass	100.4	355.5	
226.764	H	Stable	29.8	40	10.2	Pass	142.2	195.8	
248.03	H	Stable	35	47	12	Pass	124.1	9.9	

DATA SHEET		Date	12-Oct-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima

### 1. Line conduction



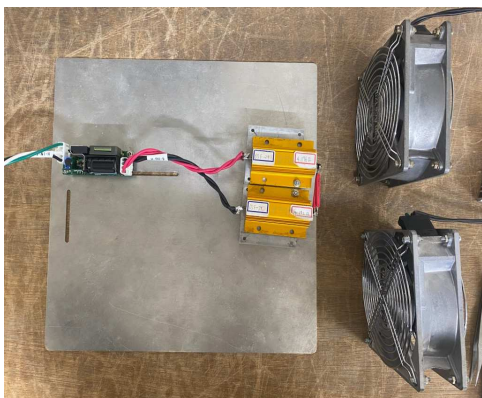
### 2. Radiated emission



## Conditions

Test : EMI  
Model Nam: TECS65F-24

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

